# 4-Channel Low Capacitance ESD Protection Array

## **Product Description**

CM1213A–04SO has been designed to provide ESD protection for electronic components or subsystems requiring minimal capacitive loading. This device is ideal for protecting systems with high data and clock rates or for circuits requiring low capacitive loading. Each ESD channel consists of a pair of diodes in series which steer the positive or negative ESD current pulse to either the positive ( $V_P$ ) or negative ( $V_N$ ) supply rail. A Zener diode is embedded between  $V_P$  and  $V_N$ , offering two advantages. First, it protects the  $V_{CC}$  rail against ESD strikes, and second, it eliminates the need for a bypass capacitor that would otherwise be needed for absorbing positive ESD strikes to ground. This device will protect against ESD pulses up to 8 kV per the IEC 61000–4–2 standard.

This device is particularly well-suited for protecting systems using high-speed ports such as USB 2.0, IEEE1394 (Firewire  $^{\textcircled{B}}$ , iLink  $^{\intercal}$ ), Serial ATA, DVI, HDMI and corresponding ports in removable storage, digital camcorders, DVD–RW drives and other applications where extremely low loading capacitance with ESD protection are required in a small package footprint.

## **Features**

- Four Channels of ESD Protection
- Provides ESD Protection to IEC61000-4-2 Level 4
  - ★ ±8 kV Contact Discharge
- Low Channel Input Capacitance of 0.85 pF Typical
- Minimal Capacitance Change with Temperature and Voltage
- Channel Input Capacitance Matching of 0.02 pF Typical is Ideal for Differential Dignals
- Zener Diode Protects Supply Rail and Eliminates the Need for External By-pass Capacitors
- Each I/O Pin Can Withstand Over 1000 ESD Strikes\*
- SZ Prefix for Automotive and Other Applications Requiring Unique Site and Control Change Requirements; AEC-Q101 Qualified and PPAP Capable
- These Devices are Pb-Free and RoHS Compliant

#### **Applications**

- USB2.0 Ports at 480 Mbps in Desktop PCs, Notebooks and Peripherals
- IEEE1394 Firewire<sup>®</sup> Ports at 400 Mbps/800 Mbps
- DVI Ports, HDMI Ports in Notebooks, Set Top Boxes, Digital TVs, LCD Displays

test to verify that all of the tested parameters are within spec after the 1000 strikes.

- Serial ATA Ports in Desktop PCs and Hard Disk Drives
- PCI Express Ports

July, 2014 - Rev. 1

• General Purpose High-Speed Data Line ESD Protection



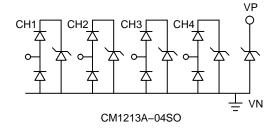
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SC-74 SO SUFFIX CASE 318F

#### MARKING DIAGRAM



### **MARKING DIAGRAM**



234 = Specific Device Code

M = Date Code

= Pb-Free Package

## ORDERING INFORMATION

(Note: Microdot may be in either location)

Device	Package	Shipping <sup>†</sup>
CM1213A-04SO	SC-74 (Pb-Free)	3,000 / Tape & Reel
SZCM1213A-04SO	SC-74 (Pb-Free)	3,000 / Tape & Reel

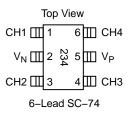
†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

\* Standard test condition is IEC61000-4-2 level 4 test circuit with each pin subjected to ±8 kV contact discharge for 1000 pulses. Discharges are timed at 1 second intervals and all 1000 strikes are completed in one continuous test run. The part is then subjected to standard production

#### **Table 1. PIN DESCRIPTIONS**

Pin	Name	Туре	Description		
1	CH1	I/O	ESD Channel		
2	V <sub>N</sub>	GND	Negative Voltage Supply Rail		
3	CH2	I/O	ESD Channel		
4	СНЗ	I/O	ESD Channel		
5	$V_P$	PWR	Positive Voltage Supply Rail		
6	CH4	I/O	ESD Channel		

#### PACKAGE/PINOUT DIAGRAMS



## **SPECIFICATIONS**

#### **Table 2. ABSOLUTE MAXIMUM RATINGS**

Parameter	Rating	Units
Operating Supply Voltage (V <sub>P</sub> – V <sub>N</sub> )	6.0	V
Operating Temperature Range	-40 to +85	°C
Storage Temperature Range	-65 to +150	°C
DC Voltage at any channel input	$(V_N - 0.5)$ to $(V_P + 0.5)$	V

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

**Table 3. STANDARD OPERATING CONDITIONS** 

Parameter	Rating	Units	
Operating Temperature Range	-40 to +85	°C	
Package Power Rating	225	mW	

Functional operation above the stresses listed in the Recommended Operating Ranges is not implied. Extended exposure to stresses beyond the Recommended Operating Ranges limits may affect device reliability.

Table 4. ELECTRICAL OPERATING CHARACTERISTICS (Note 1)

Symbol	Parameter	Conditions	Min	Тур	Max	Units
V <sub>P</sub>	Operating Supply Voltage (V <sub>P</sub> –V <sub>N</sub> )			3.3	5.5	V
Ι <sub>Ρ</sub>	Operating Supply Current	$(V_P - V_N) = 3.3 \text{ V}$			8.0	μΑ
V <sub>F</sub>	Diode Forward Voltage	I <sub>F</sub> = 8 mA; T <sub>A</sub> = 25°C		0.90		V
I <sub>LEAK</sub>	Channel Leakage Current	$T_A = 25^{\circ}C; V_P = 5 \text{ V}, V_N = 0 \text{ V}$		±0.1	±1.0	μΑ
C <sub>IN</sub>	Channel Input Capacitance	At 1 MHz, V <sub>IN</sub> = 0 V (Note 2)			2.0	pF
ΔC <sub>IO</sub>	Channel I/O ti I/O Capacitance			1.5		pF
V <sub>ESD</sub>	ESD Protection Peak Discharge Voltage at any channel input, in system Contact discharge per IEC 61000–4–2 standard	T <sub>A</sub> = 25°C (Notes 2 and 3)	±8			kV
V <sub>CL</sub>	Channel Clamp Voltage Positive Transients Negative Transients	$T_A = 25$ °C, $I_{PP} = 1$ A, $t_P = 8/20 \mu S$ (Note 2)		+9.9 -1.6		٧
R <sub>DYN</sub>	Dynamic Resistance Positive Transients Negative Transients	$T_A = 25^{\circ}C$ , $I_{PP} = 1A$ , $t_P = 8/20 \ \mu S$ (Note 2)		0.96 0.5		Ω

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

- 1. All parameters specified at  $T_A = -40^{\circ}$ C to +85°C unless otherwise noted.
- 2. Standard IEC 61000–4–2 with  $C_{Discharge}$  = 150 pF,  $R_{Discharge}$  = 330  $\Omega$ ,  $V_P$  = 3.3 V,  $V_N$  grounded.
- 3. These measurements performed with no external capacitor on V<sub>P</sub> (V<sub>P</sub> floating).

## PERFORMANCE INFORMATION

## **Input Channel Capacitance Performance Curves**

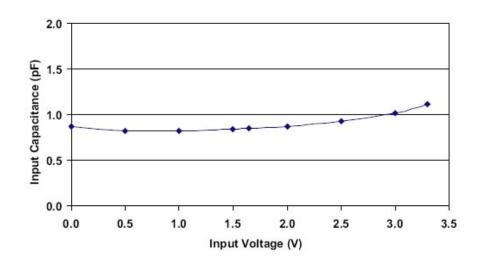


Figure 1. Typical Variation of C<sub>IN</sub> vs. V<sub>IN</sub> (f = 1 MHz, V<sub>P</sub> = 3.3 V, V<sub>N</sub> = 0 V, 0.1  $\mu$ F Chip Capacitor between V<sub>P</sub> and V<sub>N</sub>, 25°C)

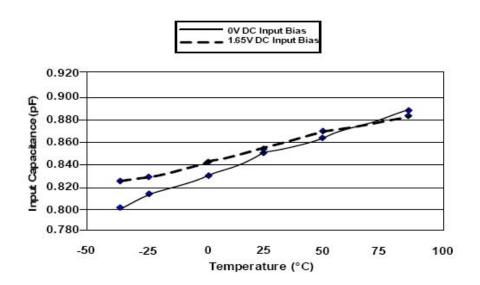


Figure 2. Typical Variation of  $C_{IN}$  vs. Temp (f = 1 MHz,  $V_{IN}$  = 30 mV,  $V_P$  = 3.3 V,  $V_N$  = 0 V, 0.1  $\mu F$  Chip Capacitor between  $V_P$  and  $V_N$ )

## PERFORMANCE INFORMATION (Cont'd)

Typical Filter Performance (nominal conditions unless specified otherwise, 50 Ohm Environment)

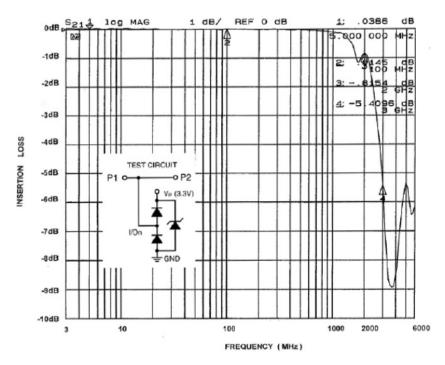


Figure 3. Insertion Loss (S21) vs. Frequency (0 V DC Bias, V<sub>P</sub>=3.3 V)

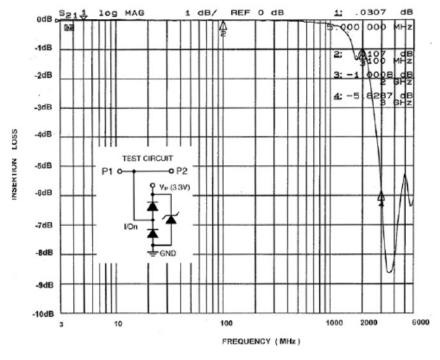


Figure 4. Insertion Loss (S21) vs. Frequency (2.5 V DC Bias, V<sub>P</sub>=3.3 V)

#### APPLICATION INFORMATION

#### **Design Considerations**

In order to realize the maximum protection against ESD pulses, care must be taken in the PCB layout to minimize parasitic series inductances on the Supply/Ground rails as well as the signal trace segment between the signal input (typically a connector) and the ESD protection device. Refer to Application of Positive ESD Pulse between Input Channel and Ground, which illustrates an example of a positive ESD pulse striking an input channel. The parasitic series inductance back to the power supply is represented by  $L_1$  and  $L_2$ . The voltage  $V_{CL}$  on the line being protected is:

## $V_{CL}$ = Fwd Voltage Drop of $D_1 + V_{SUPPLY} + L_1 \times d(I_{ESD}) / dt + L_2 \times d(I_{ESD}) / dt$

where I<sub>ESD</sub> is the ESD current pulse, and V<sub>SUPPLY</sub> is the positive supply voltage.

An ESD current pulse can rise from zero to its peak value in a very short time. As an example, a level 4 contact discharge per the IEC61000–4–2 standard results in a current pulse that rises from zero to 30 Amps in 1 ns. Here  $d(I_{ESD})/dt$  can be approximated by  $\Delta I_{ESD}/\Delta t$ , or  $30/(1x10^{-9})$ . So just 10 nH of series inductance (L<sub>1</sub> and L<sub>2</sub> combined) will lead to a 300 V increment in V<sub>CL</sub>!

Similarly for negative ESD pulses, parasitic series inductance from the  $V_N$  pin to the ground rail will lead to drastically increased negative voltage on the line being protected.

The CM1213A has an integrated Zener diode between  $V_P$  and  $V_N$ . This greatly reduces the effect of supply rail inductance  $L_2$  on  $V_{CL}$  by clamping  $V_P$  at the breakdown voltage of the Zener diode. However, for the lowest possible  $V_{CL}$ , especially when  $V_P$  is biased at a voltage significantly below the Zener breakdown voltage, it is recommended that a 0.22  $\mu F$  ceramic chip capacitor be connected between  $V_P$  and the ground plane.

As a general rule, the ESD Protection Array should be located as close as possible to the point of entry of expected electrostatic discharges. The power supply bypass capacitor mentioned above should be as close to the  $V_P$  pin of the Protection Array as possible, with minimum PCB trace lengths to the power supply, ground planes and between the signal input and the ESD device to minimize stray series inductance.

### **Additional Information**

See also ON Semiconductor Application Note "Design Considerations for ESD Protection", in the Applications section.

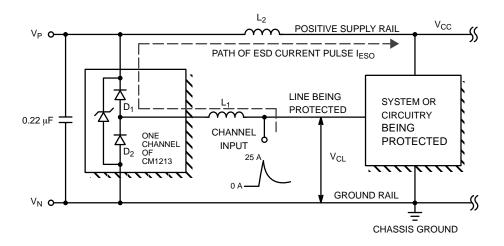
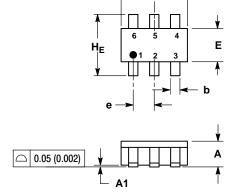
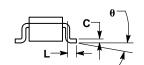


Figure 5. Application of Positive ESD Pulse between Input Channel and Ground

### PACKAGE DIMENSIONS

## SC-74 CASE 318F-05 ISSUE N



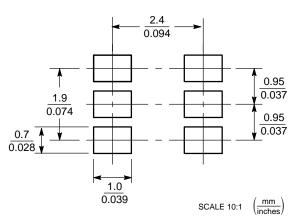


#### NOTES:

- DIMENSIONING AND TOLERANCING PER
- ANSI Y14.5M, 1982.
  2. CONTROLLING DIMENSION: INCH.
- 3. MAXIMUM LEAD THICKNESS INCLUDES LEAD FINISH THICKNESS. MINIMUM LEAD THICKNESS IS THE MINIMUM THICKNESS OF BASE MATERIAL.
- 4. 318F-01, -02, -03, -04 OBSOLETE. NEW STANDARD 318F-05.

	MILLIMETERS			INCHES		
DIM	MIN	NOM	MAX	MIN	NOM	MAX
Α	0.90	1.00	1.10	0.035	0.039	0.043
A1	0.01	0.06	0.10	0.001	0.002	0.004
b	0.25	0.37	0.50	0.010	0.015	0.020
С	0.10	0.18	0.26	0.004	0.007	0.010
D	2.90	3.00	3.10	0.114	0.118	0.122
E	1.30	1.50	1.70	0.051	0.059	0.067
е	0.85	0.95	1.05	0.034	0.037	0.041
L	0.20	0.40	0.60	0.008	0.016	0.024
HE	2.50	2.75	3.00	0.099	0.108	0.118
θ	0°	_	10°	0°	_	10°

## **SOLDERING FOOTPRINT\***



\*For additional information on our Pb–Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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